N itrogen local electronic structure in G a (In)A sN alloys by soft-X -ray absorption and em ission: Im plications for optical properties

V N. Strocov,¹; P.O. Nilsson,² T. Schmitt,³ A. Augustsson,³ L. Gridneva,³ D. Debow ska-Nilsson,² R.

¹Experim entalphysik II, Universitat Augsburg, D-86135Augsburg, Germany

²D epartm ent of P hysics, C halm ers U niversity of Technology and G oteborg U niversity, SE -41296 G oteborg, Sweden

³D epartm ent of Physics, Uppsala University, Angstrom Laboratory, Box 530, S-75121 Uppsala, Sweden

⁴A.F. Io e Physico-Technical Institute, 194021 St.Petersburg, Russia

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Soft-X -ray emission and absorption spectroscopies with their elem ental speci city are used to determ ine the local electronic structure of N atom s in G a (In) A sN diluted sem iconductor alloys (N concentrations about 3%) in view of applications of such m aterials in optoelectronics. D eviations of the N local electronic structure in Ga(In)AsN from the crystalline state in GaN are dramatic in both valence and conduction bands. In particular, a depletion of the valence band maximum in the N local charge, taking place at the N impurities, appears as one of the fundam entalorigins of reduced opticale ciency of Ga(In)AsN. Incorporation of In in large concentrations form s In-rich N local environm ents such as In4N whose the electronic structure evolves towards in proved e ciency. Furtherm ore, a k-character of som e valence and conduction states, despite the random alloy nature of G a (In) A sN, m an ifests itself in resonant inelastic X -ray scattering.

I. IN TRODUCTION

Ga(In)AsN sem iconductor alloys are new promising optoelectronic materials, whose potential applications range from e cient solar cells to laser diodes operating in the long wavelength range (1.3 m) which ts the transparency window of opto bers used in local networks. A rem arkable property of the G a (In) A sN alloys is an extrem ely strong dependence of the band gap width E_{q} on the N content, characterized by a giant bowing coe cient with $dE_q = dx = 15-20$ eV (see, e.g., Ref.¹). This gure is m ore than one order of m agnitude larger com pared to the conventional III-V alloys, which suggests that physical mechanisms to narrow the band gap are quite di erent. A disadvantage of the G a (In) A sN alloys is how ever their low opticale ciency compared to conventional III-V alloys such as G aA s and A lA s.

P hysics of G a (In)A sN and related alloys has been under intense study during the last few years (see R efs.¹⁵ and references therein). Due to a strong di erence in the N and As scattering potentials, insertion of N atom s into the host lattice results in a giant perturbation of the electronic structure and form ation of fundam entally new electronic states such as resonant in purity states.

Their hybridization with the host states in the conduction band strongly perturbs and shifts these states to lower energies, which narrows the band gap. Di erent local environments of N atoms such as isolated in purities, N-N pairs and various clusters form di erent states hybridizing with each other. Because of the immense complexity of such a system no exhaustive theoretical treatm ent exists up to now. Di erent approaches such as the empirical pseudopotential supercell method,^{1;2} rstprinciples pseudopotential method³ and band anticrossing model⁴ often give con icting predictions. Moreover, their experimental veri cation is complicated by significant scatter in the experimental results depending on the sample preparation. Despite signi cant advances in understanding of the band gap narrowing in Ga (In)AsN alloys, mechanisms responsible for degradation of their opticale ciency are still not com pletely clear.

A vast amount of the experimental data on the Ga(In)AsN and similar alloys has been obtained using optical spectroscopies such as photolum inescence (PL) and electrore ectance (see, e.g., a compilation of references in Ref.¹). However, they are largely restricted to the band gap region, and give in general only bare positions of the energy levels without any direct inform ation about spatial localization or orbital character of wavefunctions. Such an information can be achieved by soft-X-ray emission (SXE) and absorption (SXA) spectroscopies with their speci city on the chem ical element and orbital character (see, e.g., a recent review in R ef.⁶). A lthough their energy resolution, intrinsically lim ited by the core hole lifetime, never matches that of the optical spectroscopies, they give an overall picture of the electronic structure on the energy scale of the whole valence band (VB) and condiction band (CB). Moreover, as the orbital selection rules involve the core state and thus engage the VB and CB states di erent from those engaged in optical transitions, the soft-X-ray spectroscopies give a com plem entary view of the electronic structure. Because of the sm all atom ic concentrations in diluted alloys such as G a (In)A sN, and sm all crossection of the SXA and SXE processes, these experiments require the use of 3-generation synchrotron radiation sources, providing soft X-rays at high intensity and brilliance, and high-resolution SXE spectrom eters with multichanneldetection.7

Claessen,¹A.Yu.Egorov,⁴VM.Ustinov,⁴Zh.I.Alferov⁴

Extending our pilot work,⁸ we here present experim ental SXE and SXA data on Ga(In)AsN diluted alloys, which unveil the local electronic structure of N im purities through the whole VB and CB. This yields new fundam ental physics of Ga(In)AsN and related alloys, in particular, electronic structure origins of their lim ited optical e ciency, e ect of In on the N local environm ents and electronic structure, and k-character of som eVB and CB states coupled by resonant inelastic X-ray scattering (R IX S).

II. EXPER IM ENTAL PROCEDURE AND RESULTS

A . Sam ple grow th

The Ga(In)AsN samples were grown by molecular beam epitaxy (MBE) at an EP-1203 machine (Russia) equipped by solid-phase Ga, In and As sources and a radio-frequency plasm a N source. Details of the growth procedure and sample characterization are given elsewhere.⁹ Brie y, the growth was performed on a GaAs(001) substrate at 430 C in As-rich conditions. The active layer in our GaAsN and GaInAsN samples was grown, respectively, as GaAs_{0:97}N_{0:03} with a thickness of 200 A , and $In_{0:07}Ga_{0:93}As_{0:97}N_{0:03}$ with a thickness of 240 A (grow th of thicker layers was hindered by phase segregation). The concentrations of In and N were checked by high-resolution X -ray rocking curves. A bu er layer between the substrate and the Ga(In)AsN active layer, and a cap layer on top of it were grown each as a 50 A thick A IA s layer sandwiched between two 50 A thick G aA s layers. Such an insertion of wide band gap A lA s is a usualmethod to increase the PL intensity by con ning the carriers in the Ga(In)AsN layer. Moreover, a hightem perature annealing of the grown structure can be perform ed after deposition of A IAs in the cap layer without desorption of G aAs. Such an annealing lasts about 10 m inutes at 700-750 C. The resulting im provem ent of the Ga(In)AsN layer crystal quality typically increases the PL intensity by a factor of 10-20.

The annealing e ect on the local environments of N atom s is less clear. The N in purities are known to interact with each other due to long-range lattice relaxation and long tails of their wavefunctions down to N concentrations of 0.1%,¹ which translates to a characteristic interaction length of 60 A. We expect that on this length scale the annealing can promote energetically favourable N local environments. In G aA sN such envoronments are, for example, (100)-oriented N pairs.¹ In the G aInA sN quaternary alloy the situation ism ore com - plicated: whereas as-grown samples have nearly random distributions of In and N atom s with a signi cant fraction of InAs clusters having sm all chem ical bond energy, the annealing should promote formation of In-N bonds, providing better lattice m atch to the G aA s substrate and

thus m in in izing the strain energy.¹⁰ In any case, on a length scale larger than the N interaction length the annealing should improve hom ogeneity of the N concentration. This is of paramount importance, in particular, for our experiment because due to the giant bowing coe - cient of G a (In)A sN any uctuations of the N concentration should result in signi cant uctuations of the electronic structure^{11;12} and therefore in sm earing of spectral structures.

B.SXE/SXA m easurem ents

The SXE/SXA experiments were performed in MAXlab, Sweden, at the undulator beam line I511-3 equipped with a modi ed SX-700 plane grating monochromator and a high-resolution Row land-mount grazing incidence spectrometer.¹³ SXE/SXA measurements employed the N 1s core level at approximately 400 eV.

The SXA spectra were recorded in the uorescence yield (FY), because due to the thick cap layer the electron yield did not show any N 1s absorption structure. The measurements were performed in partial FY using the SXE spectrom eter operated slitless. It was adjusted at a photon energy window centered at the N K -em ission line and covering an interval, in the 1st order of di raction, from some 320 to 470 eV. The signal was detected with the spectrom eter position-sensitive detector as the integral uorescence within this energy window. Interestingly, usual measurements in the total FY (detected with a microchannel plate detector in front of the sam ple) returned considerably di erent spectra. This is possibly because the total FY is more susceptible to irrelevant contributions due to higher-order incident light and low energy photoelectron brem sstrahlung uorescence, significant with our low N concentrations in the host m aterial. As the partial FY measurements are characterized by signi cant intensity loss due to smaller acceptance angle of the spectrom eter, we operated the m onochrom ator at an energy resolution of 0.45 eV FW HM (the N 1s lifetime broadening is about 0.1 eV 18).

The synchrotron radiation excited SXE spectra were measured, in view of the low crossection of the SXE process and sm all N concentration, with the m onochrom ator resolution lowered to 1.5 eV and to 0.5 eV for the o resonance and resonant spectra, respectively. The spectrom eter was operated with a spherical grating of 5 m radius and 400 lines/mm groove density in the 1st order ofdi raction, providing a resolution of 12 eV. The signal from the position-sensitive detector was aberration corrected using 3rd-order polynom ial tting and norm alized to the total illum inated area in each channel on the detector. Norm aldata acquisition tim e was 2-5 hours per spectrum. Despite the cap layer we could also see a N signal under 3.5 keV electron beam excitation, although on top of strong brem sstrahlung background, but this was not suitable for resonant m easurem ents.

E nergy calibration of the spectrom eter was perform ed in absolute photon energies employing the NiL₁, L_{1,2} and L₁ lines seen in the 2nd order of di raction. A bberations in the dispersion direction of the position-sensitive detector were corrected by setting an energy scale as a function of the channel num ber using 2nd order polynomial tting. Based on the elastic peaks in SXE spectra, the monochrom ator was then calibrated in the same absolute energy scale with an accuracy about 0.15 eV.

C.Experim ental results

O ur experim ental N 1s SXA spectra (m easured in the partial FY)¹⁴ and o -resonant SXE spectra (excitation energy of 420 eV, well above the absorption threshold) of the G aA $s_{0:97}N_{0:03}$ and G $a_{0:93}In_{0:07}A s_{0:97}N_{0:03}$ sam ples are shown in Fig.1 (upper panel). The binding energy scale is set relative to the VB m axim um (VBM) determined, roughly, by linear extrapolation of the SXE spectral leading edge. We intentionally give the spectra without denoising to facilitate judgem ent the signi cance of the spectral structures com pared to the noise level. Recent supercell calculations by Persson and Zunger¹⁵ are in good agreem ent with our experimental results.

Recent SXA data on GaAs_{0:97}N_{0:03} by Lordi et al,¹⁶ which appeared after initial submission of this paper, are consistent with our results (apart from some energy shift which is presumably because their energy scale was a ected by the monochrom ator calibration). Previous SXA data by Soo et al¹⁷ su er from worse experimental resolution and sample quality.

Local environments of the N atom s in Ga(In)AsN are polym orphic, corresponding to isolated in purities and various clusters.¹ Applying random statistics, the concentration ratio of the pair and higher-order N clusters to the total number of N atom s is given by $1-(1-x)^m$, where x is the N concentration and m = 4 the number of the nearest anions in the zinc-blende lattice. W ith our N concentrations of 3% this ratio is only 11.5%. Therefore, our SX E /SXA spectra characterize m ainly the isolated N im purities.

III. D ISC U SSIO N

A.O verall picture of the electronic structure

The experimental SXA and o -resonance SXE spectra in Fig.1 re ect, by the dipole selection rules requiring that the orbital quantum number lischanged by 1, the p-component of the DOS locally in the N core region. The p-component, by analogy with crystalline G aN,¹⁸ should in fact dominate the total DOS through the whole VB and CB region. Core excitonic e ects are presumably less signi cant because the direct recombination peak²¹ does not show up in our SXE spectra. Splitting of the VBM into the light and heavy hole subbands due to a strain in posed by the GaAs substrate,²² being about a few tenths of eV, is below our experim ental resolution.

It is instructive to compare our G a (In)A sN spectra to the corresponding spectra of crystalline G aN. They are reproduced in Fig.1 (bwer panel) in the binding energy scale determ ined in the sam e way as for G a (In)A sN. The spectra of G aN in the m etastable zinc-blende structure, which has the same N coordination as G a (In)A sN, were m easured by Lawniczak et al.¹⁸ and those of wurtzite G aN by Stagarescu et al.¹⁹ Apart from the CB shift, the spectra of the two crystalline forms are similar in overall shape. They are well understood in terms of the local orbital-projected D O S and band structure.^{18;23}

C on parison of the SXE/SXA data on Ga(In)AsN to those on the two GaN crystalline structures shows:

(1) In the VB, the overall shape of the SXE signal for G a (In)A sN is similar to crystalline G aN. How ever, the spectral maximum is strongly shifted towards the VB interior, with the leading edge at the VBM being much less steep (which has in portant in plications for optical e ciency, see below). This is not a resolution e ect, because the reference spectra of crystalline G aN were taken at close resolution gures (around 0.8 eV for zinc-blende G aN and 1.1 eV for wurtzite G aN). Our experimental data demonstrate thus that the VB electronic structure undergoes, contrary to the common point of view, significant changes upon incorporation of N atoms into G aAs. Interestingly, our SXE spectrum did not show any structure due to hybridization with the G a 3d states at 19 eV below the VBM, found in wurtzite G aN ;^{19;20}

(2) In the CB, the di erences are radical. The leading peak of the SXA spectrum for Ga(In)AsN rises immediately at the CB m inimum (CBM) and has much larger amplitude compared to the leading shoulder-like structure in the spectra of crystalline GaN. The energy separation between the VB and CB states for Ga(In)AsN is m uch sm aller, which correlates with sm aller fundamental band gap.

On the whole, the observed di erences of the Ga(In)AsN spectra to crystalline GaN manifest that the local electronic structure of the N atoms in the Ga(In)AsN random alloy is radically di erent from that in the regular GaN lattice.

A lthough further theoretical analysis is required to interpret our experimental data in detail, we can tentatively assign the leading SXA peak to the t_2 (L_{1c}) derived perturbed host state which, according to the calculations by K ent and Zunger on G aA sN¹, has the strongest N localization in the CBM region. This assignment is corroborated by the resonant SXE data (see below) which reveals the L-character of the leading SXA peak.

It should be noted that the dipole selection rules in SXE/SXA, inherently involving transitions from and to the core level, project out the states from the VB and CB, which can di er from those projected out by the optical transitions between the VB and CB states them selves. For example, delocalized states can give only a sm all con-

tribution to the SXE/SXA signal due to relatively sm all overlap with the core state, but they can strongly overlap with each other and give a strong PL signal. Our SXA data give explicit examples of this: The a_1 ($_{1c}$) derived states near the CBM (see $Ref.^1$) are not seen in the SXA spectrum due to the weaker N localization com pared to the t_2 (L_{1c}) states, but in optical spectroscopies they manifest them selves as the intense E transitions. On the other hand, the t_2 (L_{1c}) states are not seen in the optical spectra due to unfavorable m atrix elements, but show up as a prominent SXA peak. Moreover, the energy separation between the VB and CB states in the SXE/SXA spectra gives only an upper estimate for the fundam entalband gap, because weakly localized N states as well as G a and A s derived states are not seen. Therefore, the SXE/SXA spectroscopies give a view of the VB and CB com plem entary to that by optical spectroscopies.

B.Charge depletion in the VBM :O rigin of reduced optical e ciency

The vast body of optical spectroscopy data on Ga(In)AsN evidences that the optical e ciency sharply drops upon incorporation of the smallest N concentrations into GaAs, and then decreases further with increase of the N m olar fraction (see, e.g., a com pilation in Ref.⁵). This is most pronounced for GaAsN, where the PL intensity loss towards N concentrations of 5% is at least 50 times as compared to GaAs. Exact origins of such a dram atic e ciency degradation are not com pletely clear. Supercell calculations in R ef.²⁴ suggest that about 30% of the GaAse ciency is lost due to gradual smearing of VBM and CBM in their -character, which results in reduction of the optical transition matrix elem ent. However, this e ect is by far weaker com pared to the experim ental degradation. A nother known origin is relatively poor structural quality of G a (In) A sN layers epitaxially grown on GaAs. This is due to, rstly, low grow th tem peratures which are used with large N concentrations to prom ote high N uptake and, secondly, som e lattice mism atch between Ga (In) AsN and GaAs. However, the rst problem can be alleviated by post-grow th high-tem perature annealing, and the second by tuning the In concentration in GaInAsN which allowsmatching the GaAs lattice constant. A lthought the PL intensity from lattice-matched GaInAsN layers does increase by a factor about 5 com pared to G aA sN, this still rem ains by far low com pared to G aAs. M oreover, the structural quality does not explain the e ciency drop at the smallest N concentrations.

O ur SX E /SX A results unveilanother origin of the opticale ciency degradation in the very electronic structure. By virtue of the N localization of the CBM wavefunction¹ the N in purities act as the main recombination centers in G a (In)A sN . At the same time, the local valence charge at the N in purities is shifted o the VBM. This appears in mediately from comparison of our experimental SXE spectra of G a (In) A sN with those of crystalline G aN, which are in fact representative of G aA s by virtue of qualitatively sim ilar valence D O S of these m aterials²⁵ (direct m easurem ents on G aA s are hindered by very low

uorescence yield of As in the soft-X -ray region). Such a charge depletion in the VBM, equivalent to reduction of the VBM wavefunction amplitude, results in a weak overlap of the CBM and VBM wavefunctions at the N impurities, which immediately reduces e ciency of the N impurities as radiative recombination centers. This VBM depletion e ect, characteristic of isolated N impurities, is one of fundamental origins of the reduced opticale ciency of Ga(In)A sN. Being in play already at the smallest N concentrations, it immediately explains the initial e ciency drop, whereas further e ciency degradation with increase of N concentration is presumably through the structural quality e ects.

To explain the observed VBM charge depletion, in Ref.⁸ we suggested a VBM charge transfer o the N atoms in Ga(In)AsN compared to GaN (in Ref.¹⁵ this our statem ent was misinterpreted as a charge transfer to As, but N has larger electronegativity). In fact, the charge transfer is more likely to take place not in space but in energy towards deeper valence states, which is supported by recent computational analysis of Persson and Zunger.¹⁵ Physically, the local electronic structure of the N impurities in the GaAs lattice appears som ewhere in between that of the crystalline state, and that of isolated atoms. The observed DOS peaked near the VB center can therefore be viewed as a transitional case between the DOS of extended band states piling up near the band edges, and the singularity-like DOS of isolated atom s at the VB center.

Form ation of N local environments di erent from the isolated impurities can be suggested as a way to increase the opticale ciency of G a (In)A sN. For example, in multiatom ic N local environments such as clusters of G a separated N atom s the wavefunctions may become closer to crystalline G aN with its D O S piling up at the VBM. Based on the random statistics, the cluster concentration should increase with the total N concentration. A lternatively, the N local environments can be changed by replacing some neighbour G a atom s by di erent cations.

C.E ect of In

Q uatemary G aInA sN alloys, where som e G a atom s are replaced by In, allow in provement of the optical e – ciency by a factor about 5. This is predom inantly due to two factors: a better lattice m atch of G aInA sN layers to the G aA s substrate, which in proves their structural quality, and electron con nement e ects connected with concentration uctuations.¹¹ W e here endevoured investigation whether the incorporation of In also causes any favourable changes in the electronic structure.

At relatively low In concentrations, evolution of the

N local electronic structure is evidenced by comparison of the G $a_{0:93}$ In_{0:07}A $s_{0:97}$ N_{0:03} and G aA $s_{0:97}$ N_{0:03} experimental spectra in Fig.1. The SXE spectra zoom ed in the VB region are also shown in Fig.2. Surprisingly, the comparison shows no notable changes within the experimental statistics, nor in the spectral shapes, neither in energies of the spectral structures. This evidences that despite the high-temperature annealing the N atom s reside mostly in In-depleted local environments such as G a_4 N and possibly²⁶ In₁G a_3 N where the presence of only one In atom in 4 nearest neighbours should not change the N local electronic structure dram atically. This experimental

nding seriously questions results of recent M onte C arlo simulations¹⁰ which predict predom inance of In-rich N local environments such as G a₁In₃N and In₄N, at least with low In concentrations. Any elects connected with insu cient annealing of our samples can be nuled out, as evidenced by stabilization of PL spectra already after 5 m in of annealing. The absence of any signi cant electronic structure changes in G a_{0:93}In_{0:07}A s_{0:97}N _{0:03} com – pared to G aA s_{0:97}N _{0:03} suggests that at low In concentrations the optical electron connected is exclusively due to the structural and electron connected structural and electron connected structural structura structura structural structural s

To force form ation of In-rich N local environments, we have grown a sample of G $a_{0:69}$ In_{0:31}A $s_{0:98}$ N_{0:02} (170 A thick active layer) where the In/N concentration ratio is much increased (the decrease in bare N concentration of the isolated N in purifies in such diluted alloys should be weak). The experimental SXE spectrum of G $a_{0:69}$ In_{0:31}A $s_{0:98}$ N_{0:02}, measured under the same o - resonance conditions as in Fig.1, is also shown in Fig.2. Now the spectral maximum is shifted by some 0.25 eV to higher energies compared to G aA $s_{0:97}$ N_{0:03}, indicating changes in the N local electronic structure caused by In-rich N environments. Interestingly, the XAS data for G $a_{0:7}$ In_{0:3}A $s_{0:97}$ N_{0:03} from R ef.¹⁶ demonstrates the CBM simultaneously shifts to low er energies.

The observed VB and CB shifts towards each other suggest that the In-rich N environments become the main recombination centers in GaInAsN. Moreover, both holes and electrons become con ned in In-reach regions formed by statistical uctuations of In concentration on m-scale. This e ect increases the optical e ciency of GaInAsN.¹¹

To see whether the observed changes in the VB a ect the optical e ciency within the above VBM depletion m echanism, we exam need closely the VBM region (insert in Fig.2). The shift of the spectral maximum is de nitely larger than that of the VBM (although its exact location requires better statistics). This indicates certain charge accumulation at the VBM compared to G aA $s_{0:97}N_{0:03}$, and thus increase of the optical e ciency of In-rich N local environments compared to G a4N. The observed accumulation seems though rather subtle to explain the increase in G aInA sN wholly, and the most of it still resides with the structural and electron con nement e ects.

D.k-conservation in the R IX S process

R esonant phenom ena were investigated on the G aA sN prototype alloy. Fig.3 shows resonant SXE spectra m easured with excitation energies near the two dom inant SXA structures in Fig.1 com pared to that m easured well above the absorption threshold. The spectra are norm alized to the integral excitation ux, which was registered from the photocurrent at a gold m esh inserted after the refocussing m irror.

Intriguingly, not only does the intensity of the resonant spectra increase in this R IX S process, but also the shoulder at the VB bottom scales up and becomes a distinct narrow peak at a binding energy of 7.4 eV. Such a behavior reveals states near the VB bottom which e ectively overlap with states near the CB bottom into which the core electron is excited.

Despite the random alloy nature of G a (In)A \pm N, the observed e ect can be interpreted in terms of m om entum conservation which appears in the R IX S process due to coupling of absorption and em ission in one single event (\pm , e.g., Refs.^{6;27;28} and references therein). At rst glance, this should not occur in a random alloy, because the very concept of m om entum, strictly speaking, collapses due to the lack of translational invariance. How – ever, the description in terms of wavevectors k can be revived using a spectral decom position

$$\sum_{k}^{N} (\mathbf{r}) = \sum_{k}^{X} C_{k} \sum_{k}^{GaAs} (\mathbf{r})$$

of the N-localized wavefunction $^{\rm N}$ (r) over the B loch waves $_{\rm k}^{{\rm G}\,aA\,s}$ (r) of the unperturbed G aA s lattice, each having a well-de ned k^{1;29} Then the rst SXA peak is due to the t₂ (L_{1c}) state, whose decomposition is dom – inated by k from the L-point in the Brillouin zone of G aA s.¹ The VB bottom, by analogy with the zinc-blende G aN band structure,³⁰ should be dom inated by the sam e L-point. The R IX S process will then couple these points in the CB and VB, blowing up the SXE signal in the VB bottom as observed in the experiment. Our resonant data dem onstrate thus, to our know ledge for the

rst time, a possibility for the k-conserving RIXS phenomenon in random alloys.

IV . C O N C LU S IO N

Local electronic structure of N atom s in G a (In)A sN diluted sem iconductor alloys (N concentrations about 3%) has been determ ined using SX E /SX A spectroscopies with their elemental speci city. The experimental N 1s o -resonance SX E spectra and SX A spectra yield the bcal p-D O S of N impurities through the whole VB and C B, com plementing information about the band gap region achieved by optical spectroscopies. The experimental results demonstrate dramatic di erences of the N local

electronic structure in Ga(In)AsN from that in the crystalline GaN state. A few peculiarities have immediate in plications for optical properties: (1) The N in purities are characterized by depletion of the the local charge in the VBM due to charge transfer tow ards deeper valence states, which reduces overlap with the CBM states. This is one of the fundam ental origins of the reduced optical e ciency of Ga(In)AsN. Formation of di erent N local environments can improve the e ciency; (2) W hereas incorporation of In in sm all concentrations has an insignificant e ect on the N local electronic structure, large In concentrations result in form ation of In-rich N local environm ents whose electronic structure evolves tow ards im proved opticale ciency. Furtherm ore, the experim ental resonant SXE spectra reveal, despite the random alloy nature of G a (In) A sN, a k-conserving R IX S process which couples valence and conduction states having the same L-character.

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Contact author, em ail strocov@physik.uni-augsburg.de

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FIG.1. (upper panel) Experim ental N 1s o -resonant SX E (excitation energy 420 eV) and SX A spectra of G aA $s_{0:97}N_{0:03}$ and G $a_{0:93}In_{0:07}As_{0:93}N_{0:03}$, re ecting the N local p-DOS through the VB and CB; (lower panel) The corresponding spectra of crystalline G aN in the zinc-blende¹⁸ and wurtzite structures¹⁹ shown as a reference. The SX E spectral m aximum for G a (In)A sN is strongly shifted to lower energies com – pared to the crystalline state, resulting in depletion of the N local charge in the VBM which reduces optical e ciency.

FIG.2. Experimental o -resonant N1s SXE spectrum of In-rich G $a_{0:69} In_{0:31}A s_{0:98}N_{0:02}$ compared to G aA $s_{0:93}N_{0:03}$. The insert details the spectral leading edges (G aussian sm oothed with FW HM of 0.6 eV) which suggest improved opticale ciency of In-rich N local environments.

FIG.3. Resonant SXE spectra with the indicated excitation energies compared to an o -resonant spectrum. The elastic peaks are marked by vertical ticks. The resonant intensity enhancement in the VB bottom manifests a k-conserving RIXS process.

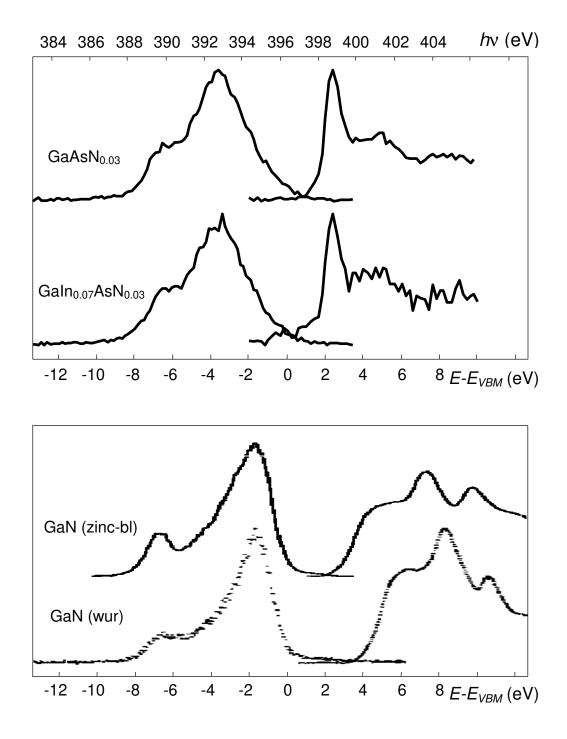


Fig.1 by Strocov et al

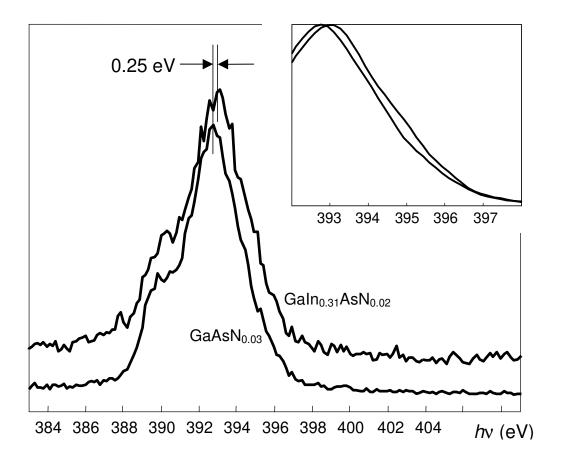


Fig.2 by Strocov et al

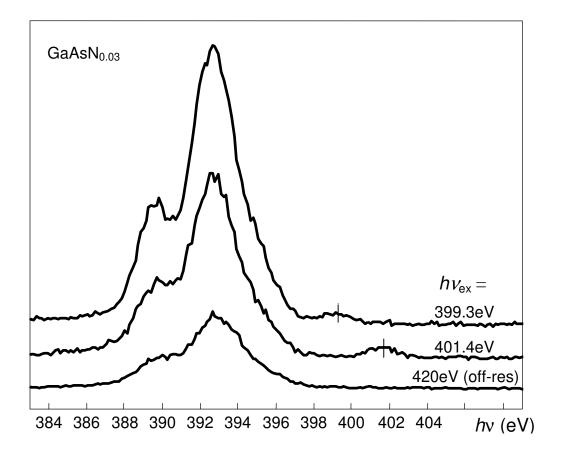


Fig.3 by Strocov et al